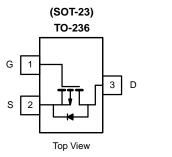
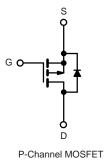


### TSM2323CX RF-VB Datasheet

## P-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Typ.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
	0.046 at V <sub>GS</sub> = - 10 V	- 5.6	
- 30	0.049 at V <sub>GS</sub> = - 6 V	- 5	11.4 nC
	0.054 at V <sub>GS</sub> = - 4.5 V	-4.5	





#### FEATURES

- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested

**APPLICATIONS** 

For Mobile Computing
 Load Switch

- DC/DC Converter

- Notebook Adaptor Switch



Maximum

<b>ABSOLUTE MAXIMUM RATIN</b>	<b>GS</b> (T <sub>A</sub> = 25 °C	, unless otherw	vise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 30	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		- 5.6	
Continuous Drain Current ( $T_1 = 150 \ ^{\circ}C$ )	T <sub>C</sub> = 70 °C		- 5.1	
Continuous Drain Current $(1_j = 150^{\circ} C)$	T <sub>A</sub> = 25 °C		- 5.4 <sup>b,c</sup>	
	T <sub>A</sub> = 70 °C		- 4.3 <sup>b,c</sup>	А
Pulsed Drain Current (t = 100 µs)		I <sub>DM</sub>	- 18	
Continous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	- 2.1	
Continous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is —	- 1 <sup>b,c</sup>	
	T <sub>C</sub> = 25 °C		2.5	
Movimum Dower Dissinction	T <sub>C</sub> = 70 °C		1.6	W
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.25 <sup>b,c</sup>	vv
	T <sub>A</sub> = 70 °C	1	0.8 <sup>b,c</sup>	
Operating Junction and Storage Temperature	Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
		- 3		

# THERMAL RESISTANCE RATINGS Parameter Symbol Typical Maximum.lunction-to-Ambient<sup>b,d</sup> t < 5 s</td> Rts. to 75

Maximum Junction-to-Ambient <sup>b,d</sup>	t ≤ 5 s	R <sub>thJA</sub>	75	100	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	40	50	0/11
Nataa					

Notes: a Based on  $T_{-} = 25 \,^{\circ}C$ 

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.

Unit

Parameter	Symbol	rwise noted) Test Conditions	Min.	Tim	Max.	Unit
Static	Symbol	Test conditions	win.	Тур.	wax.	Unit
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 30		1	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	VGS = 0 V, ID = 200 µA	- 30	- 19		v
	20 0	I <sub>D</sub> = - 250 μA		-		mV/°
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	0.5	4	0.0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>		- 0.5		- 2.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 1 - 5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 V$ , $V_{GS} = -10 V$	- 2.5			Α
	( )	V <sub>GS</sub> =- 10 V, I <sub>D</sub> = - 4.4 A		0.046		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> =- 6 V, I <sub>D</sub> = - 4 A		0.049		Ω
		V <sub>GS</sub> =- 4.5 V, I <sub>D</sub> = - 3.6 A		0.054		-
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 3.4 A		18		S
Dynamic <sup>b</sup>				!	Į	ļ
Input Capacitance	C <sub>iss</sub>			1295		[
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		150		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			130		-
		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5.4 A		24	36	
Total Gate Charge	Qg			11.4	17	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5.4 A		3.4		
Gate-Drain Charge	Q <sub>gd</sub>			3.8		
Gate Resistance	Rg	f = 1 MHz	1.5	7.7	15.4	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			13	20	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = - 15 V, R <sub>I</sub> = 3.5 Ω		4	8	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 4.3 A, $V_{GEN}$ = - 10 V, $R_q$ = 1 $\Omega$		38	57	
Fall Time	t <sub>f</sub>			6	12	-
Turn-On Delay Time	t <sub>d(on)</sub>			28	42	ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = - 15 V, R <sub>I</sub> = 3.5 Ω		16	24	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -4.3 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		30	45	-
Fall Time	t <sub>f</sub>			10	20	
Drain-Source Body Diode Characteristic						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 2.1	
Pulse Diode Forward Current (t = 100 µs)	I <sub>SM</sub>	-			- 80	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 4.3 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	23	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1		7	14	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = - 4.3 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		8		
Reverse Recovery Rise Time	t <sub>b</sub>	4		7		ns

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

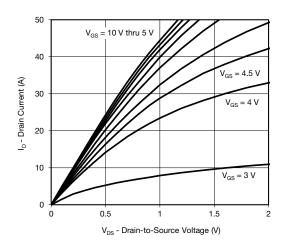
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

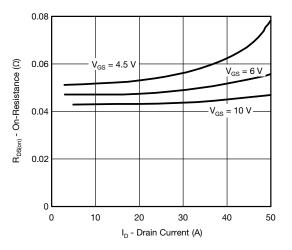




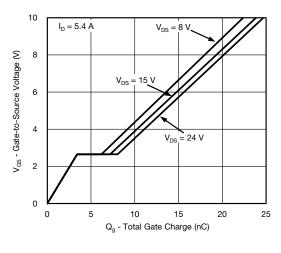




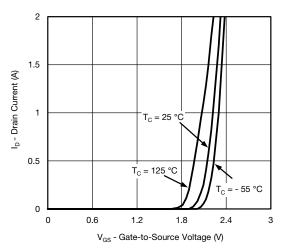
**Output Characteristics** 



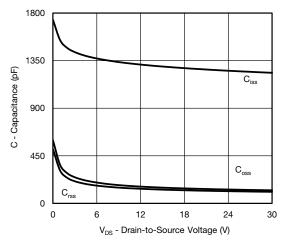
**On-Resistance vs. Drain Current** 



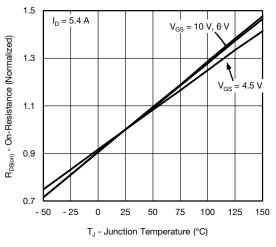
**Gate Charge** 



**Transfer Characteristics** 



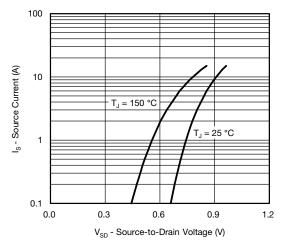
Capacitance



**On-Resistance vs. Junction Temperature** 



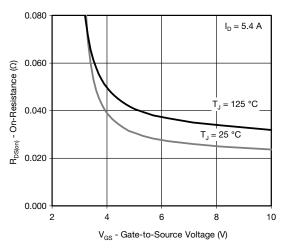
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



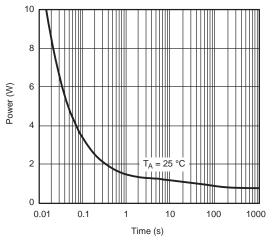
Source-Drain Diode Forward Voltage



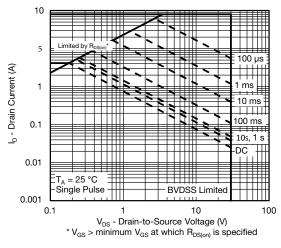
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



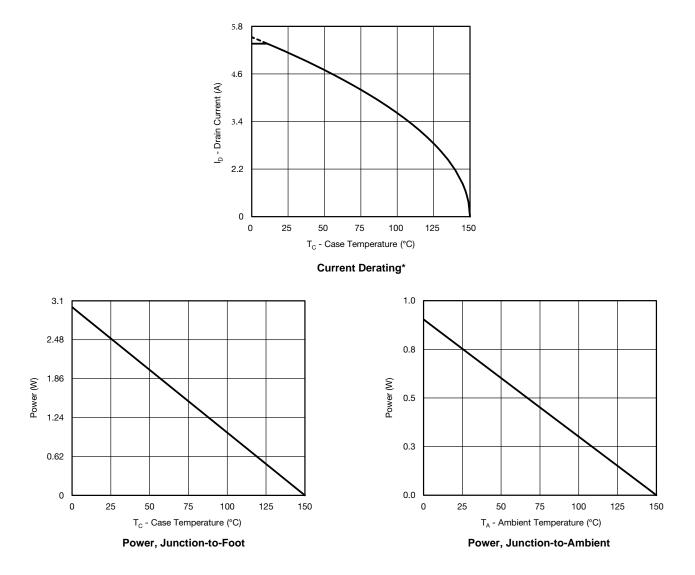
Single Pulse Power (Junction-to-Ambient)



Safe Operating Area, Junction-to-Ambient



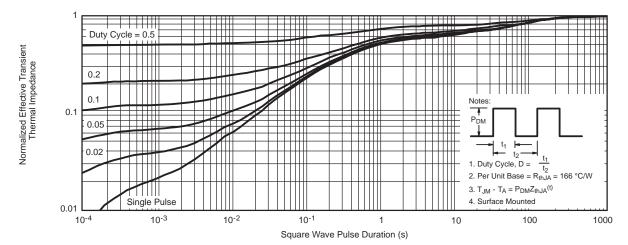
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



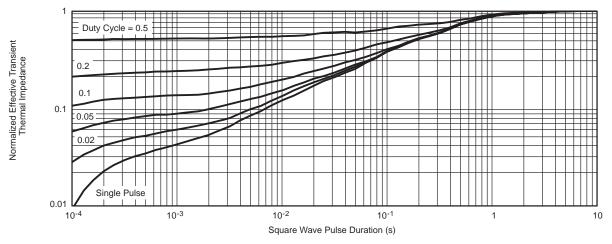
\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



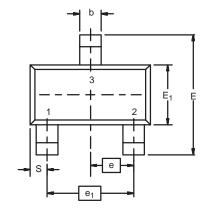
Normalized Thermal Transient Impedance, Junction-to-Ambient

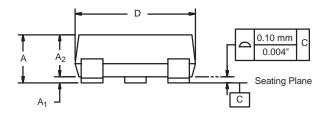


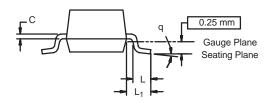
Normalized Thermal Transient Impedance, Junction-to-Foot



#### SOT-23 (TO-236): 3-LEAD



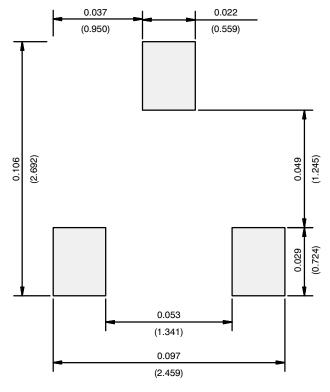




Max           1.12           0.10           1.02           0.50           0.18           3.04           2.64           1.40	Min           0.035           0.0004           0.0346           0.014           0.003           0.110           0.083	Max           0.044           0.004           0.040           0.020           0.007           0.120           0.104		
0.10 1.02 0.50 0.18 3.04 2.64	0.0004 0.0346 0.014 0.003 0.110 0.083	0.004 0.040 0.020 0.007 0.120		
1.02 0.50 0.18 3.04 2.64	0.0346 0.014 0.003 0.110 0.083	0.040 0.020 0.007 0.120		
0.50 0.18 3.04 2.64	0.014 0.003 0.110 0.083	0.020 0.007 0.120		
0.18 3.04 2.64	0.003 0.110 0.083	0.007 0.120		
3.04 2.64	0.110 0.083	0.120		
2.64	0.083			
		0.104		
1.40	0.047			
	0.047	0.055		
0.95 BSC	0.037	4 Ref		
1.90 BSC		0.0748 Ref		
0.60	0.016	0.024		
0.64 Ref	0.025	5 Ref		
0.50 Ref	0.020	) Ref		
8°	3°	8°		
_	0.64 Ref 0.50 Ref	0.64 Ref 0.025 0.50 Ref 0.026		



#### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)



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